Silicon Carbide Power Schottky Diode Chip

Features

- 8000 V Silicon Carbide Schottky rectifier
- 175 °C maximum operating temperature
- Positive temperature coefficient of V_F
- Extremely fast switching speeds
- Superior figure of merit Q_C/I_F

Advantages

- Improved circuit efficiency (Lower overall cost)
- Low switching losses
- Ease of paralleling devices without thermal runaway
- Smaller heat sink requirements
- Low reverse recovery current
- Low device capacitance
- Low reverse leakage current at operating temperature

Maximum Ratings at T_j = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values	Unit
Repetitive peak reverse voltage	V_{RRM}		8000	V
Continuous forward current	I_F		50	mA
RMS forward current	$I_{F(RMS)}$		87	mA
Power dissipation	P_{tot}	T_C = 25 °C	0.2	W
Operating and storage temperature	T_j , T_{stg}		-55 to 175	°C

Electrical Characteristics at T_j = 175 °C, unless otherwise specified

Parameter	Symbol	Conditions	Values			Unit
			min.	typ.	max.	
Diode forward voltage	V_F	I_F = 50 mA, T_j = 25 °C		4.6		V
		I_F = 50 mA, T_j = 175 °C		12		
Reverse current	I_R	V_R = 8000 V, T_j = 25 °C		3.8		μA
		V_R = 8000 V, T_j = 125 °C		5.3		
Total capacitance	C	V_R = 1 V, f = 1 MHz, T_j = 25 °C		25		pF
		V_R = 400 V, f = 1 MHz, T_j = 25 °C		8		
		V_R = 1000 V, f = 1 MHz, T_j = 25 °C		6		

***For chip size and metallization, please refer to the mechanical datasheet (must have a non-disclosure agreement with GeneSiC Semiconductor).**

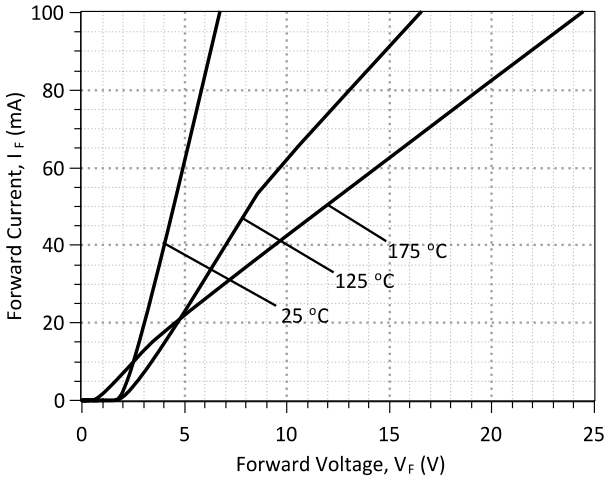

Figure 1: Typical Forward Characteristics

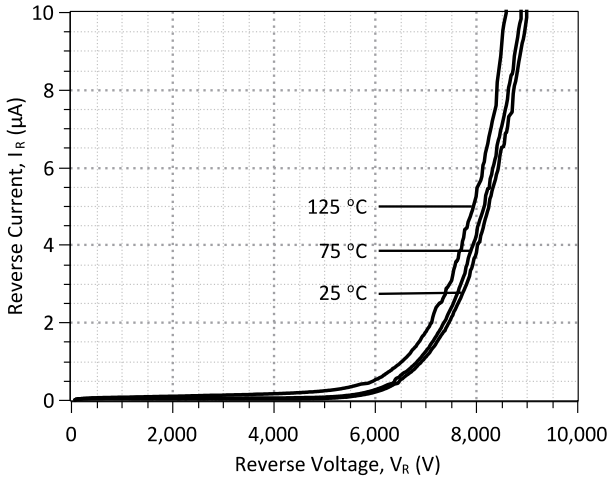

Figure 2: Typical Reverse Characteristics

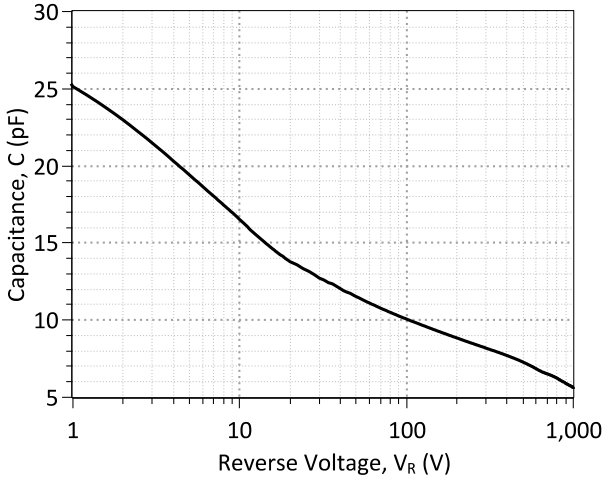

Figure 3: Typical Junction Capacitance vs Reverse Voltage Characteristics

Revision History			
Date	Revision	Comments	Supersedes
2013/03/19	1	Added C-V characteristics	
2012/11/28	0	Initial release	

Published by
GeneSiC Semiconductor, Inc.
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Dulles, VA 20166

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SPICE Model Parameters

Copy the following code into a SPICE software program for simulation of the GAP05SLT80_CAL device.

```
*     MODEL OF GeneSiC Semiconductor Inc.
*
*     $Revision:   1.0           $
*     $Date:   26-AUG-2013       $
*
*     GeneSiC Semiconductor Inc.
*     43670 Trade Center Place Ste. 155
*     Dulles, VA 20166
*     httphttp://www.genesicsemi.com/index.php/sic-products/schottky
*
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*
* These models are provided "AS IS, WHERE IS, AND WITH NO WARRANTY
* OF ANY KIND EITHER EXPRESSED OR IMPLIED, INCLUDING BUT NOT LIMITED
* TO ANY IMPLIED WARRANTIES OF MERCHANTABILITY AND FITNESS FOR A
* PARTICULAR PURPOSE."
* Models accurate up to 2 times rated drain current.
*
* Start of GAP05SLT80-CAL SPICE Model
.SUBCKT GAP05SLT80_CAL ANODE KATHODE
R1 ANODE INT R=((TEMP-24)*0.81); Temperature Dependant Resistor
D1 INT KATHODE GAP05SLT80_CAL_25C
.MODEL GAP05SLT80_CAL_25C D; Model of GAP05SLT80-CAL Device at 25 C
+ IS       14.067E-15
+ N        1.3760
+ RS       42.6
+ IKF      157.39E-6
+ EG       1.2
+ XTI      -85
+ CJO      21.838E-12
+ M        0.258
+ VJ       3.198
+ BV       9000
+ IBV      1E-3
+ TT       1.0000E-10
+ VPK      8000
+ IAVE     3E-2
+ TYPE     SiC_Schottky
+ MFG      GeneSiC_Semiconductor
.ENDS
*
* End of GAP05SLT80-CAL SPICE Model
```